

# FSAM15SH60A Motion SPM<sup>®</sup> 2 Series

September 2013

### **Features**

- UL Certified No. E209204
- 600 V 15 A 3 Phase IGBT Inverter Bridge Including Control ICs for Gate Driving and Protection
- Three Separate Open Emitter Pins from Low Side IGBTs for Three Leg Current Sensing
- Single-Grounded Power Supply Thanks to Built-in HVIC
- Typical Switching Frequency of 15 kHz
- · Built-in Thermistor for Temperature Monitoring
- Inverter Power Rating of 0.8 kW / 100~253 VAC
- Isolation Rating of 2500 Vrms / min.
- Low Thermal Resistance by Using Ceramic Substrate
- Adjustable Current Protection Level by Changing the Value of Series Resistor Connected to the Emitters of Sense-IGBTs

## **Applications**

• Motion Control - Home Appliance / Industrial Motor

### **General Description**

FSAM15SH60A Is A Motion SPM® 2 Series that Fairchild Has Developed to Provide A Very Compact and Low Cost, yet High Performance Inverter Solution for AC Motor Drives in Low-Power Applications Such as Air Conditioners. It Combines Optimized Circuit Protections and Drive Matched to Low-Loss IGBTs. Effective Over-Current Protection Is Realized Through Advanced Current Sensing IGBTs. The System Reliability Is Further Enhanced by The Built-in Thermistor and Integrated Under-Voltage Lock-Out Protection. In Addition The Incorporated HVIC Facilitates The Use of Single-Supply Voltage Without Any Negative Bias. Inverter Leg Current Sensing Can Be Implemented Because of Three Separate Nagative DC Terminals.

#### **Related Source**

• AN-9043 : Motion SPM® 2 Series User's Guide

# Top View Bottom View





Fig. 1.

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Package	Reel Size	Packing Type	Quantity
FSAM15SH60A	FSAM15SH60A	S32AA-032	-	RAIL	8

### **Integrated Power Functions**

• 600 V - 15 A IGBT inverter for 3-phase DC/AC power conversion (Please refer to Fig. 3)

### Integrated Drive, Protection and System Control Functions

- For inverter high-side IGBTs: Gate drive circuit, High voltage isolated high-speed level shifting Control circuit under-voltage (UV) protection
  - Note) Available bootstrap circuit example is given in Figs. 14 and 15.
- For inverter low-side IGBTs: Gate drive circuit, Short-Circuit (SC) protection
   Control supply circuit under-voltage (UV) protection
- Temperature Monitoring: System over-temperature monitoring using built-in thermistor
   Note) Available temperature monitoring circuit is given in Fig. 15.
- Fault signaling: Corresponding to a SC fault (Low-side IGBTs) or a UV fault (Low-side control supply circuit)
- Input interface: Active Low Interface, Can Work with 3.3 / 5 V Logic

## **Pin Configuration**

### **Top View**

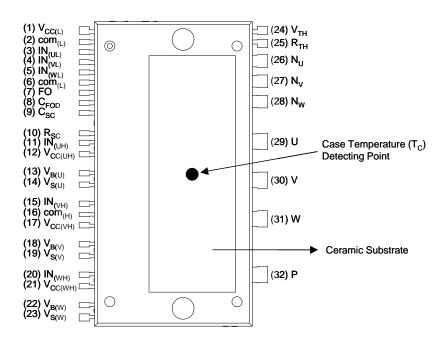
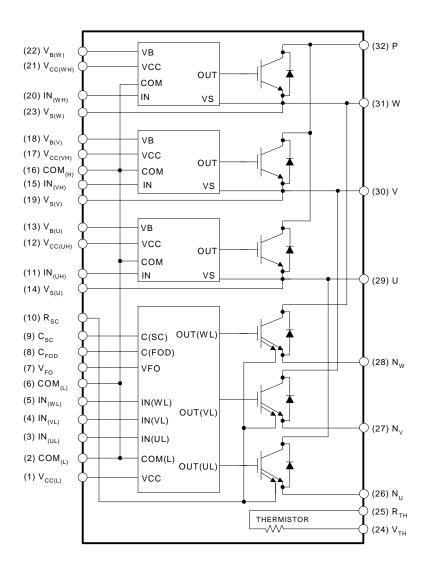


Fig. 2.

Pin Descr	riptions	
Pin Number	Pin Name	Pin Description
1	V <sub>CC(L)</sub>	Low-side Common Bias Voltage for IC and IGBTs Driving
2	COM <sub>(L)</sub>	Low-side Common Supply Ground
3	IN <sub>(UL)</sub>	Signal Input for Low-side U Phase
4	IN <sub>(VL)</sub>	Signal Input for Low-side V Phase
5	IN <sub>(WL)</sub>	Signal Input for Low-side W Phase
6	COM <sub>(L)</sub>	Low-side Common Supply Ground
7	$V_{FO}$	Fault Output
8	C <sub>FOD</sub>	Capacitor for Fault Output Duration Time Selection
9	C <sub>SC</sub>	Capacitor (Low-pass Filter) for Short-Circuit Current Detection Input
10	R <sub>SC</sub>	Resistor for Short-Circuit Current Detection
11	IN <sub>(UH)</sub>	Signal Input for High-side U Phase
12	V <sub>CC(UH)</sub>	High-side Bias Voltage for U Phase IC
13	$V_{B(U)}$	High-side Bias Voltage for U Phase IGBT Driving
14	V <sub>S(U)</sub>	High-side Bias Voltage Ground for U Phase IGBT Driving
15	$IN_{(VH)}$	Signal Input for High-side V Phase
16	COM <sub>(H)</sub>	High-side Common Supply Ground
17	V <sub>CC(VH)</sub>	High-side Bias Voltage for V Phase IC
18	$V_{B(V)}$	High-side Bias Voltage for V Phase IGBT Driving
19	$V_{S(V)}$	High-side Bias Voltage Ground for V Phase IGBT Driving
20	IN <sub>(WH)</sub>	Signal Input for High-side W Phase
21	V <sub>CC(WH)</sub>	High-side Bias Voltage for W Phase IC
22	$V_{B(W)}$	High-side Bias Voltage for W Phase IGBT Driving
23	V <sub>S(W)</sub>	High-side Bias Voltage Ground for W Phase IGBT Driving
24	$V_{TH}$	Thermistor Bias Voltage
25	$R_{TH}$	Series Resistor for the Use of Thermistor (Temperature Detection)
26	$N_{U}$	Negative DC–Link Input for U Phase
27	$N_V$	Negative DC–Link Input for V Phase
28	$N_W$	Negative DC-Link Input for W Phase
29	U	Output for U Phase
30	V	Output for V Phase
31	W	Output for W Phase
32	Р	Positive DC-Link Input

# **Internal Equivalent Circuit and Input/Output Pins**

#### **Bottom View**



- Note:

  1 Inverter low-side is composed of three sense-IGBT including freewheeling diodes for each IGBT and one control IC which has gate driving, current sensing and protection functions.

  2) Inverter power side is composed of four inverter dc-link input pins and three inverter output pins.

  3) Inverter high-side is composed of three normal-IGBTs including freewheeling diodes and three drive ICs for each IGBT.

Fig. 3.

# **Absolute Maximum Ratings** $(T_J = 25^{\circ}C, Unless Otherwise Specified)$

### **Inverter Part**

Item	Symbol	Condition	Rating	Unit
Supply Voltage	V <sub>PN</sub>	Applied between P- N <sub>U</sub> , N <sub>V</sub> ,N <sub>W</sub>	450	V
Supply Voltage (Surge)	V <sub>PN(Surge)</sub>	Applied between P- N <sub>U</sub> , N <sub>V</sub> ,N <sub>W</sub>	500	V
Collector-Emitter Voltage	V <sub>CES</sub>		600	V
Each IGBT Collector Current	± I <sub>C</sub>	T <sub>C</sub> = 25°C	15	Α
Each IGBT Collector Current	± I <sub>C</sub>	T <sub>C</sub> = 100°C	11	Α
Each IGBT Collector Current (Peak)	± I <sub>CP</sub>	T <sub>C</sub> = 25°C, Instantaneous Value (Pulse)	30	А
Collector Dissipation	P <sub>C</sub>	T <sub>C</sub> = 25°C per One Chip	50	W
Operating Junction Temperature	TJ	(Note 1)	-20 ~ 125	°C

## **Control Part**

Item	Symbol	Condition	Rating	Unit
Control Supply Voltage	$V_{CC}$	Applied between V <sub>CC(UH)</sub> , V <sub>CC(VH)</sub> , V <sub>CC(WH)</sub> - COM <sub>(H)</sub> ,	20	V
		$V_{CC(L)}$ - $COM_{(L)}$		
High-side Control Bias Voltage	$V_{BS}$	Applied between $V_{B(U)}$ - $V_{S(U)}$ , $V_{B(V)}$ - $V_{S(V)}$ , $V_{B(W)}$ -	20	V
		$V_{S(W)}$		
Input Signal Voltage	$V_{IN}$	Applied between IN <sub>(UH)</sub> , IN <sub>(VH)</sub> , IN <sub>(WH)</sub> - COM <sub>(H)</sub>	-0.3 ~ V <sub>CC</sub> +0.3	V
		$IN_{(UL)}, IN_{(VL)}, IN_{(WL)} - COM_{(L)}$		
Fault Output Supply Voltage	$V_{FO}$	Applied between V <sub>FO</sub> - COM <sub>(L)</sub>	-0.3 ~ V <sub>CC</sub> +0.3	V
Fault Output Current	I <sub>FO</sub>	Sink Current at V <sub>FO</sub> Pin	5	mA
Current Sensing Input Voltage	V <sub>SC</sub>	Applied between C <sub>SC</sub> - COM <sub>(L)</sub>	-0.3 ~ V <sub>CC</sub> +0.3	V

# **Total System**

Item	Symbol	Condition	Rating	Unit
Self Protection Supply Voltage Limit (Short-Circuit Protection Capability)	V <sub>PN(PROT)</sub>	$V_{CC} = V_{BS} = 13.5 \sim 16.5 \text{ V}$ $T_J = 125^{\circ}\text{C}$ , Non-repetitive, less than $6\mu\text{s}$	400	V
Module Case Operation Temperature	T <sub>C</sub>	Note Fig.2	-20 ~ 100	°C
Storage Temperature	T <sub>STG</sub>		-20 ~ 125	°C
Isolation Voltage	V <sub>ISO</sub>	60 Hz, Sinusoidal, AC 1 minute, Connection Pins to Heat-sink Plate	2500	V <sub>rms</sub>

Note:

1. It would be recommended that the average junction temperature should be limited to  $T_J \le 125^{\circ}C$  (@ $T_C \le 100^{\circ}C$ ) in order to guarantee safe operation.

# **Absolute Maximum Ratings**

## **Thermal Resistance**

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Junction to Case Thermal Resistance	R <sub>th(j-c)Q</sub>	Each IGBT under Inverter Operating Condition	-	-	2.5	°C/W
	R <sub>th(j-c)F</sub>	Each FWDi under Inverter Operating Condition	-	-	3.6	°C/W
Contact Thermal Resistance	R <sub>th(c-h)</sub>	Ceramic Substrate (per 1 Module) Thermal Grease Applied (Note 3)	-	ı	0.06	°C/W

- Note:
  2. For the measurement point of case temperature(T<sub>C</sub>), please refer to Fig. 2.
  3. The thickness of thermal grease should not be more than 100um.

# $\textbf{Electrical Characteristics} \quad (T_J = 25^{\circ}C, \text{ Unless Otherwise Specified})$

## **Inverter Part**

Item	Symbol	Conditi	on	Min.	Тур.	Max.	Unit
Collector - Emitter	V <sub>CE(SAT)</sub>	$V_{CC} = V_{BS} = 15 \text{ V}$ $V_{IN} = 0 \text{ V}$	$I_C = 15 \text{ A}, T_J = 25^{\circ}\text{C}$	-	-	2.5	V
Saturation Voltage		$V_{IN} = 0 V$	$I_C = 15 \text{ A}, T_J = 125^{\circ}\text{C}$	-	-	2.6	V
FWDi Forward Voltage	$V_{FM}$	V <sub>IN</sub> = 5 V	$I_C = 15 \text{ A}, T_J = 25^{\circ}\text{C}$	-	-	2.5	V
			$I_C = 15 \text{ A}, T_J = 125^{\circ}\text{C}$	-	-	2.3	V
Switching Times	t <sub>ON</sub>	$V_{PN} = 300 \text{ V}, V_{CC} = V_{BS} = 1$	5 V	-	0.34	-	us
	t <sub>C(ON)</sub>	$I_C = 15 \text{ A}, T_J = 25^{\circ}\text{C}$		-	0.15	-	us
	t <sub>OFF</sub>	$V_{IN} = 5 \text{ V} \leftrightarrow 0 \text{ V}$ , Inductive L	oad	-	0.73	-	us
	t <sub>C(OFF)</sub>	(High, Low-side)		-	0.24	-	us
	t <sub>rr</sub>	(Note 4)		-	0.13	-	us
Collector -Emitter Leakage Current	I <sub>CES</sub>	$V_{CE} = V_{CES}, T_{J} = 25^{\circ}C$		-	-	250	μА

4. toN and toFF include the propagation delay time of the internal drive IC. t<sub>C(ON)</sub> and t<sub>C(OFF)</sub> are the switching time of IGBT itself under the given gate driving condition internally. For the detailed information, please see Fig. 4.

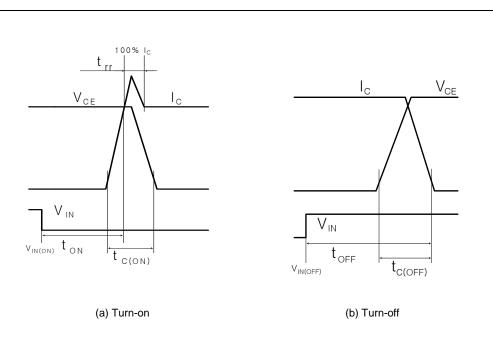


Fig. 4. Switching Time Definition

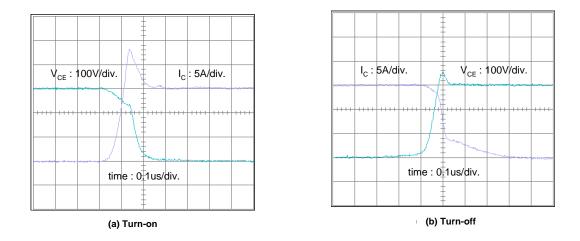


Fig. 5. Experimental Results of Switching Waveforms Test Condition: Vdc=300 V, Vcc=15 V, L=500 uH (Inductive Load),  $\rm T_{j}$ =25°C

# **Electrical Characteristics** $(T_J = 25$ °C, Unless Otherwise Specified) **Control Part**

Item	Symbol		Condition	Min.	Тур.	Max.	Unit
Control Supply Voltage	V <sub>CC</sub>	Applied between		13.5	15	16.5	V
		V <sub>CC(UH)</sub> , V <sub>CC(VH)</sub> , V <sub>CC</sub>					
High-side Bias Voltage	$V_{BS}$	Applied between V <sub>B(L</sub>	$V_{S(U)}, V_{S(V)} - V_{S(V)},$	13.5	15	16.5	V
		V <sub>B(W)</sub> - V <sub>S(W)</sub>					
Quiescent V <sub>CC</sub> Supply Cur-	IQCCL	$V_{CC} = 15 \text{ V}$	V <sub>CC(L)</sub> - COM <sub>(L)</sub>	-	-	26	mA
rent		IN <sub>(UL, VL, WL)</sub> = 5 V					
	Гассн	V <sub>CC</sub> = 15 V	V <sub>CC(UH)</sub> , V <sub>CC(VH)</sub> , V <sub>CC(WH)</sub> -	-	-	130	uA
0.4		IN <sub>(UH, VH, WH)</sub> = 5 V	COM <sub>(H)</sub>			400	
Quiescent V <sub>BS</sub> Supply Cur- rent	I <sub>QBS</sub>	V <sub>BS</sub> = 15 V	$V_{B(U)} - V_{S(U)}, V_{B(V)} - V_{S(V)},$	-	-	420	uA
Fault Output Voltage	\/	$IN_{(UH, VH, WH)} = 5 V$	VB(W) VS(W) t: 4.7 kΩ to 5 V Pull-up	4.5	_	_	V
i auli Ouipui vollage	V <sub>FOH</sub>			-	_	1.1	V
PWM Input Frequency	V <sub>FOL</sub>	$V_{SC} = 1 \text{ V}, V_{FO} \text{ Circuit: } 4.7 \text{ k}\Omega \text{ to 5 V Pull-up}$		_	15	-	kHz
	f <sub>PWM</sub>	$T_C \le 100^{\circ}\text{C}, T_J \le 125^{\circ}\text{C}$		2	15		
Allowable Input Signal Blanking Time considering	t <sub>dead</sub>	$-20$ °C $\leq$ T <sub>C</sub> $\leq$ 100°C		2	-	-	us
Leg Arm-short							
Short-Circuit Trip Level	V <sub>SC(ref)</sub>	V <sub>CC</sub> = 15 V (Note 5)		0.45	0.51	0.56	V
Sensing Voltage	V <sub>SEN</sub>	$T_C = 25^{\circ}C$ , @ $R_{SC} = 3$	$50 \Omega$ , $R_{SU} = R_{SV} = R_{SW} = 0 \Omega$	0.45	0.51	0.56	V
of IGBT Current	J	and I <sub>C</sub> = 22.5 A (Note	Fig. 7)				
Supply Circuit Under-	UV <sub>CCD</sub>	Detection Level		11.5	12	12.5	V
Voltage Protection	UV <sub>CCR</sub>	Reset Level		12	12.5	13	V
	UV <sub>BSD</sub>	Detection Level		7.3	9.0	10.8	V
	UV <sub>BSR</sub>	Reset Level		8.6	10.3	12	V
Fault Output Pulse Width	t <sub>FOD</sub>	C <sub>FOD</sub> = 33 nF (Note 6)		1.4	1.8	2.0	ms
ON Threshold Voltage	V <sub>IN(ON)</sub>	High-Side	Applied between IN <sub>(UH)</sub> , IN <sub>(VH)</sub> ,	-	-	0.8	V
OFF Threshold Voltage	V <sub>IN(OFF)</sub>		IN <sub>(WH)</sub> - COM <sub>(H)</sub>	3.0	-	-	V
ON Threshold Voltage	V <sub>IN(ON)</sub>	Low-Side	Applied between IN(UL), IN(VL),	-	-	0.8	V
OFF Threshold Voltage	V <sub>IN(OFF)</sub>		IN <sub>(WL)</sub> - COM <sub>(L)</sub>	3.0	-	-	V
Resistance of Thermistor	R <sub>TH</sub>	@ T <sub>TH</sub> = 25°C (Note I	Fig. 6)	-	50	-	kΩ
		@ T <sub>TH</sub> = 100°C (Note		-	3.4	-	kΩ

<sup>Note:
5. Short-circuit current protection is functioning only at the low-sides. It would be recommended that the value of the external sensing resistor (R<sub>SC</sub>) should be selected around 50 Ω in order to make the SC trip-level of about 22.5A at the shunt resistors (R<sub>SU</sub>,R<sub>SV</sub>,R<sub>SW</sub>) of 0Ω . For the detailed information about the relationship between the external sensing resistor (R<sub>SC</sub>) and the shunt resistors (R<sub>SU</sub>,R<sub>SV</sub>,R<sub>SW</sub>), please see Fig. 7.
6. The fault-out pulse width t<sub>FOD</sub> depends on the capacitance value of C<sub>FOD</sub> according to the following approximate equation: C<sub>FOD</sub> = 18.3 x 10<sup>-6</sup> x t<sub>FOD</sub>[F]
7. T<sub>TH</sub> is the temperature of thermistor</sup> 

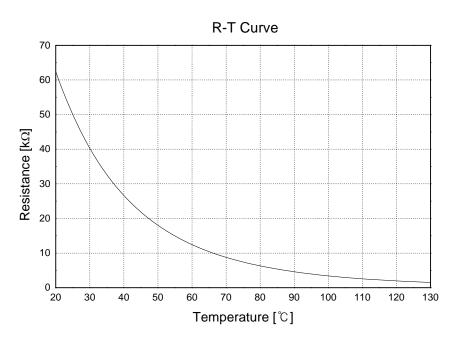


Fig. 6. R-T Curve of The Built-in Thermistor

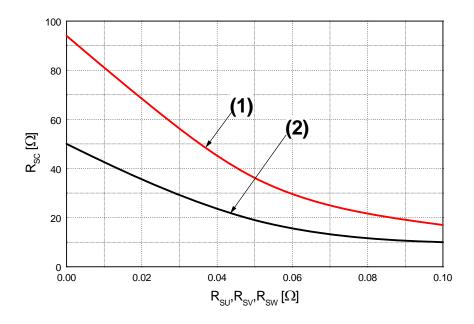


Fig. 7. R<sub>SC</sub> Variation by change of Shunt Resistors (R<sub>SU</sub>, R<sub>SV</sub>, R<sub>SW</sub>) for Short-Circuit Protection (1) @ around 100% Rated Current Trip (I<sub>C</sub> '=. 15 A) (2) @ around 150% Rated Current Trip (I<sub>C</sub> '=. 22.5 A)

# **Mechanical Characteristics and Ratings**

Item		Condition		Limits			
item		Condition				Unit	
Mounting Torque	Mounting Screw: M4	Recommended 10 Kg•cm	8	10	12	Kg•cm	
	(Note 8 and 9)	Recommended 0.98 N•m	0.78	0.98	1.17	N•m	
Ceramic Flatness		Note Fig.8	0	-	+120	um	
Weight			-	35	-	g	

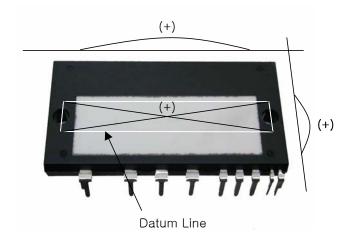


Fig. 8. Flatness Measurement Position of The Ceramic Substrate

- Note:

  8. Do not make over torque or mounting screws. Much mounting torque may cause ceramic cracks and bolts and Al heat-fin destruction.

  9. Avoid one side tightening stress. Fig.9 shows the recommended torque order for mounting screws. Uneven mounting can cause the Motion SPM® 2 Package ceramic substrate to be damaged.

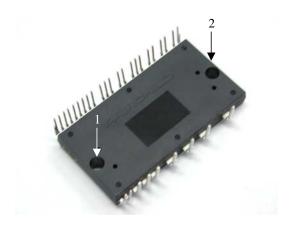
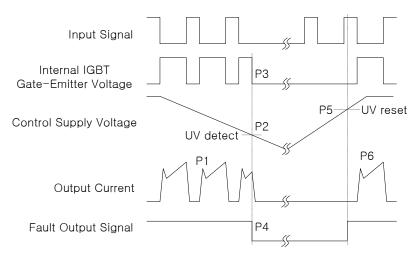


Fig. 9. Mounting Screws Torque Order

# **Recommended Operating Conditions**

ltam	Symbol Condition			Unit		
Item			Min.	Тур.	Max.	Unit
Supply Voltage	$V_{PN}$	Applied between P - N <sub>U</sub> , N <sub>V</sub> , N <sub>W</sub>	-	300	400	V
Control Supply Voltage	V <sub>CC</sub>	$ \begin{array}{c} \text{Applied between V}_{\text{CC(UH)}},  \text{V}_{\text{CC(VH)}},  \text{V}_{\text{CC(WH)}} - \\ \text{COM}_{\text{(H)}},  \text{V}_{\text{CC(L)}} - \text{COM}_{\text{(L)}} \end{array} $	13.5	15	16.5	٧
High-side Bias Voltage	V <sub>BS</sub>	Applied between $V_{B(U)}$ - $V_{S(U)}$ , $V_{B(V)}$ - $V_{S(V)}$ , $V_{B(W)}$ - $V_{S(W)}$	13.5	15	16.5	<b>V</b>
Blanking Time for Preventing Arm-short	t <sub>dead</sub>	For Each Input Signal	3	-	-	us
PWM Input Signal	f <sub>PWM</sub>	$T_C \le 100$ °C, $T_J \le 125$ °C	-	15	-	kHz
Input ON Threshold Voltage	V <sub>IN(ON)</sub>	Applied between IN <sub>(UH)</sub> , IN <sub>(VH)</sub> , IN <sub>(WH)</sub> - COM <sub>(H)</sub>		0 ~ 0.65	5	>
Input OFF Threshold Voltage	V <sub>IN(OFF)</sub>	Applied between $IN_{(UL)}$ , $IN_{(VL)}$ , $IN_{(WL)}$ - $COM_{(L)}$		4 ~ 5.5		V

### **Time Charts of Protective Function**

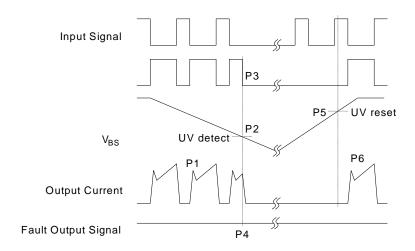


P1: Normal operation - IGBT ON and conducting current

P2 : Under-Voltage detection P3 : IGBT gate interrupt P4 : Fault signal generation P5 : Under-Voltage reset

P6: Normal operation - IGBT ON and conducting current

Fig. 10. Under-Voltage Protection (Low-side)

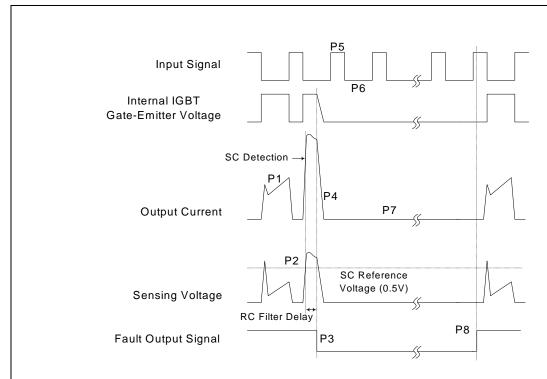


P1: Normal operation - IGBT ON and conducting current

P2: Under-Voltage detection P3: IGBT gate interrupt P4: No fault signal P5: Under-Voltage reset

P6: Normal operation - IGBT ON and conducting current

Fig. 11. Under-Voltage Protection (High-side)



P1: Normal operation - IGBT ON and conducting current

P2 : Short-Circuit current detection

P3: IGBT gate interrupt / Fault signal generation

P4: IGBT is slowly turned off

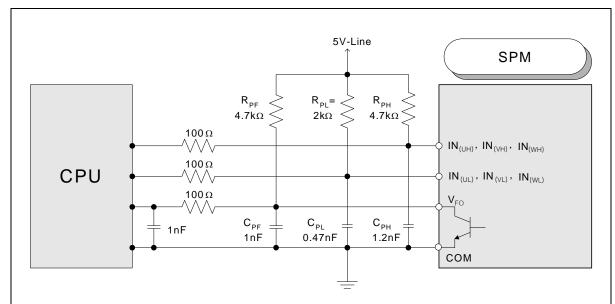
P5: IGBT OFF signal

P6: IGBT ON signal - but IGBT cannot be turned on during the fault Output activation

P7: IGBT OFF state

P8 : Fault Output reset and normal operation start

Fig. 12. Short-Circuit Current Protection (Low-side Operation only)



#### Note:

- Note:

  1) It would be recommended that by-pass capacitors for the gating input signals, IN<sub>(UL)</sub>, IN<sub>(VL)</sub>, IN<sub>(UL)</sub>, IN<sub>(UH)</sub>, IN<sub>(UH)</sub>, IN<sub>(UH)</sub> and IN<sub>(WH)</sub> should be placed on the Motion SPM® 2 Product pins and on the both sides of CPU and Motion SPM 2 Product for the fault output signal, V<sub>FO</sub>, as close as possible.

  2) The logic input is compatible with standard CMOS or LSTTL outputs.

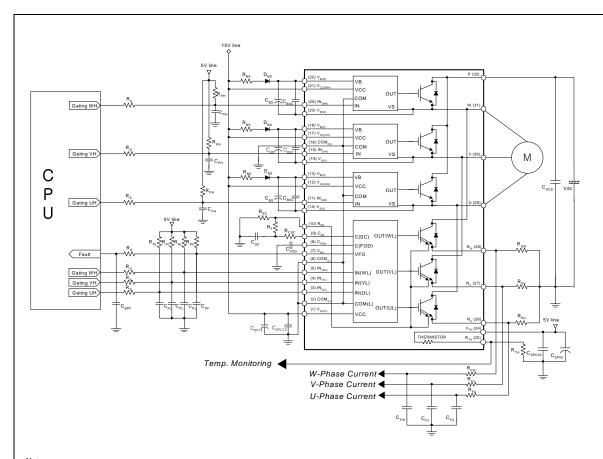
  3) R<sub>PL</sub>C<sub>PL</sub>/R<sub>PH</sub>C<sub>PH</sub>/R<sub>PF</sub>C<sub>PF</sub> coupling at each Motion SPM 2 Product input is recommended in order to prevent input/output signals' oscillation and it should be as close as possible to each of Motion SPM 2 Product pins.

Fig. 13. Recommended CPU I/O Interface Circuit

### These Values depend on PWM Control Algorithm 15V-Line One-Leg Diagram of Motion SPM® 2 Product Ρ $D_{\text{\footnotesize{BS}}}$ **20**Ω 0.1uF VB Vcc IN НО 22uF COM VS Inverter -Output / Vcc 470uF > 0.1uF IN OUT СОМ Ν

**Note:**It would be recommended that the bootstrap diode, D<sub>BS</sub>, has soft and fast recovery characteristics.

Fig. 14. Recommended Bootstrap Operation Circuit and Parameters



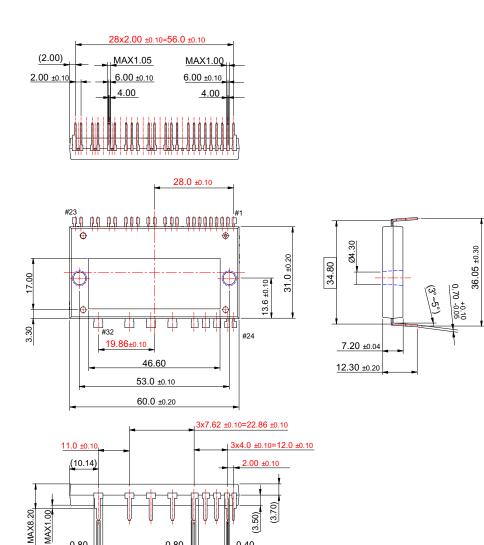
- 1) R<sub>PL</sub>C<sub>PL</sub>/R<sub>PH</sub>C<sub>PH</sub>/R<sub>PF</sub>C<sub>PF</sub> coupling at each Motion SPM<sup>®</sup> 2 Product input is recommended in order to prevent input signals' oscillation and it should be as close as possible to each Motion SPM 2 Product input pin.
- 2) By virtue of integrating an application specific type HVIC inside the Motion SPM 2 Product, direct coupling to CPU terminals without any opto-coupler or transformer isolation is possible.
- $^{3}$  V $_{FO}$  output is open collector type. This signal line should be pulled up to the positive side of the 5V power supply with approximately  $4.7k\Omega$  resistance. Please refer to Fig. 15.
- $C_{\text{SP15}}$  of around 7 times larger than bootstrap capacitor  $C_{\text{BS}}$  is recommended.
- V<sub>FO</sub> output pulse width should be determined by connecting an external capacitor(C<sub>FOD</sub>) between C<sub>FOD</sub>(pin8) and COM<sub>(L)</sub>(pin2). (Example : if C<sub>FOD</sub> = 33 nF, then
- to the coupling circuits at each input may be needed depending on the PWM control scheme used and on the wiring impedance of the system's printed circuit board).
- Approximately a 0.22–2nF by-pass capacitor should be used across each power supply connection terminals. To prevent errors of the protection function, the wiring around  $R_{SC}$ ,  $R_F$  and  $C_{SC}$  should be as short as possible. In the short-circuit protection circuit, please select the  $R_FC_{SC}$  time constant in the range 3–4  $\mu$ s. Each capacitor should be mounted as close to the pins of the Motion SPM 2 Product as possible.

- 10)To prevent surge destruction, the wiring between the smoothing capacitor and the P&N pins should be as short as possible. The use of a high frequency non-inductive capacitor of around 0.1~0.22 uF between the P&N pins is recommended.
- 11)Relays are used at almost every systems of electrical equipments of home appliances. In these cases, there should be sufficient distance between the CPU and the relays. It is recommended that the distance be 5cm at least.

Fig. 15. Typical Application Circuit

# **Detailed Package Outline Drawings**

# S32AA-032



Dimensions in Millimeters

MAX3.20

MAX2.50

MAX1.60



#### **TRADEMARKS**

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

 2Cool™
 FPS™

 AccuPower™
 F.PFS™

 AX-CAP®\*
 FRFET®

 BitSiC™
 Global Power Resource®

 Build it Now™
 GreenBridge™

CorePLUS™ Green FPS™
CorePOWER™ Green FPS™ e-Series™
CROSSVOLT™ Gmax™

CTL™ GTO™

Current Transfer Logic™ IntelliMAX™

DEUXPEED® ISOPLANAR™

Dual Cool™ Making Small Speakers Sound Louder EcoSPARK® and Better™

ECOSPARK and Better \*\*

EfficientMax™ MegaBuck™

ESBC™ MICROCOUPLER™

MicroFET™

MicroFET™

Fairchild®
Fairchild®
Fairchild Semiconductor®
FACT Quiet Series™
FACT®
FAST®
FastvCore™
FastvCore™
FETBench™

MicroPak™
MotionMax™
mVSaver™
OptoHiT™
OPTOLOGIC®
OPTOPLANAR®

PowerTrench® PowerXS™ Programmable Act

Programmable Active Droop™

QFET<sup>®</sup>
QS™
Quiet Series™
RapidConfigure™

Saving our world, 1mW/W/kW at a time™

SignalWise™ SmartMax™ SMART START™

Solutions for Your Success™

SPM®
STEALTH™
SuperFET®
SuperSOT™-3
SuperSOT™-6
SuperSOT™-8
SupreMOS®
SyncFET™

SYSTEM
GENERAL®

TinyBoost™
TinyBuck™
TinyCogic®
TinYOPTO™
TinyPower™
TinyPWM™
TinyWM™
TranSiC™
TriFault Detect™
TRUECURRENT®
µSerDes™

UHC<sup>®</sup>
UHTA FRFET™
UniFET™
VCX™
VisualMax™
VoltagePlus™
XS™

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

#### PRODUCT STATUS DEFINITIONS

### **Definition of Terms**

Datasheet Identification	<b>Product Status</b>	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed Full Production		Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 164

<sup>\*</sup> Trademarks of System General Corporation, used under license by Fairchild Semiconductor.